

Search Notes

Application/Control No.

10/601,124

Examiner

Jack I. Berman

Applicant(s)/Patent under
Reexamination

CHEN, ZHONG-WEI

Art Unit

2881

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-----------------------------------|-----------|----------|
| 250 | 310 307 396ML 397 398 | 5/11/2005 | JB |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--------------|-----------|----------|
| 250 | 310 307 | 5/11/2005 | JB |
| 250 | 396ML 397 | 5/11/2005 | JB |
| 250 | 398 | 5/11/2005 | JB |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-----------------------|----------------|------------|
| EAST search enclosed. | 5/11/2005 | JB |
| <i>Reviewed</i> | <i>5/12/05</i> | <i>JBW</i> |
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